IN THE CLAIMS

This listing of claims replaces all prior versions and listings of claims in the abovereferenced application.

- 1-8. (Canceled).
- 9. (Previously Presented) A method of forming a light emitting device, the method comprising:

forming a first semiconductor layer of a first conductivity type and having a first surface;

forming an active region over the first semiconductor layer, the active region including at least two quantum well layers separated by a barrier layer, wherein one of a quantum well layer and the barrier layer is a graded layer formed from a III-Nitride semiconductor alloy of $\ln_x A \ln_y G a_{1-x-y} N$ where $0 \le x \le 1$, $0 \le y \le 1$, $x + y \le 1$, the graded layer having a composition graded in a direction substantially perpendicular to the first surface of the first semiconductor layer; and

forming a third semiconductor layer of a second conductivity type over the active region.

- (Previously Presented) The method of Claim 9, wherein the graded layer has a wurtzite crystal structure.
- 11. (Previously Presented) The method of Claim 9, further comprising grading the composition of the III-Nitride semiconductor alloy in the graded layer asymmetrically.
- 12. (Previously Presented) The method of Claim 9, further comprising grading the composition of the III-Nitride semiconductor alloy in the graded layer to reduce the effect of a piezoelectric field in the active region.
- 13. (Previously Presented) The method of Claim 9, further comprising grading a mole fraction of the III-Nitride semiconductor alloy in the graded layer linearly.
 - 14. (Canceled).
- 15. (Previously Presented) The method of Claim 14, further comprising grading the mole fraction of indium in the graded layer.
- 16. (Previously Presented) The method of Claim 14, further comprising grading the mole fraction of aluminum in the graded layer.
- 17. (Previously Presented) The method of Claim 9, wherein the active region is formed directly on the first semiconductor layer.

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- 18. (Withdrawn) A light emitting device comprising:
- a first semiconductor layer of a first conductivity type having a first surface;

an active region overlying the first semiconductor layer, the active region including a plurality of quantum well layers and at least one barrier layer, the barrier layer formed from a III-Nitride semiconductor alloy having an indium mole fraction graded in a direction substantially perpendicular to the first surface of the first semiconductor layer; and

another semiconductor layer of a second conductivity type overlying the active region.

- 19. (Withdrawn) The light emitting device of Claim 18, wherein the barrier layer has a wurtzite crystal structure.
- 20. (Withdrawn) The light emitting device of Claim 18, wherein the indium mole fraction of the III-Nitride semiconductor alloy is graded asymetrically.
- 21. (Withdrawn) The light emitting device of Claim 18, wherein the indium mole fraction of the III-Nitride semiconductor alloy is graded to reduce an effect of a piezoelectric field in the active region.
- 22. (Withdrawn) The light emitting device of Claim 18, wherein the indium mole fraction of the III-Nitride semiconductor alloy is graded linearly.
- 23. (Withdrawn) The light emitting device of Claim 18, wherein the III-Nitride semiconductor alloy is $In_xAl_yGa_{1-x-y}N$ where $0 \le x \le 1$, $0 \le y \le 1$, and $x + y \le 1$.
- 24. (Withdrawn) The light emitting device of Claim 18, wherein the active region includes a plurality of barrier layers each formed from a III-Nitride semiconductor alloy having an indium mole fraction graded in a direction substantially perpendicular to the first surface of the first semiconductor layer.
- 25. (Previously Presented) A method of forming a light emitting device, the method comprising:

forming a first semiconductor layer of a first conductivity type having a first surface; forming an active region overlying the first semiconductor layer, the active region including a plurality of quantum well layers separated by at least one barrier layer, the barrier layer formed from a III-Nitride semiconductor alloy of $In_xAl_yGa_{1-x-y}N$ where $0 \le x \le 1$, $0 \le y \le 1$, $x + y \le 1$, the barrier layer having an indium mole fraction graded in a direction substantially perpendicular to the first surface of the first semiconductor layer; and

forming another semiconductor layer of a second conductivity type overlying the active region.

26. (Original) The method of Claim 25, further comprising forming the barrier

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PATENT LAW GROUP I.LP 2033 N. FIRST ST. SUITH 123 EAN IOSE, CA 95134 (408) 382-040 layer in a wurtzite crystal structure.

- 27. (Original) The method of Claim 25, further comprising grading the indium mole fraction of the III-Nitride semiconductor alloy asymmetrically.
- 28. (Original) The method of Claim 25, further comprising grading the indium mole fraction of the III-Nitride semiconductor alloy to reduce an effect of a piezoelectric field in the active region.
- 29. (Original) The method of Claim 25, further comprising grading the indium mole fraction of the III-Nitride semiconductor alloy linearly.
 - 30. (Canceled).
- 31. (Original) The method of Claim 25, wherein the active region includes a plurality of barrier layers each formed from a III-Nitride semiconductor alloy having an indium mole fraction graded in a direction substantially perpendicular to the first surface of the first semiconductor layer.
- 32. (Previously Presented) The method of Claim 25, further comprising grading an indium mole fraction of at least one of the plurality of quantum well layers.
- 33. (Previously Presented) The method of Claim 9 wherein the graded layer has a graded composition of a first element, wherein a change in composition of the first element in the graded layer is 1% per angstrom across a thickness of the graded layer.

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